

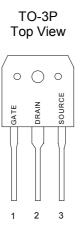
GENERAL DESCRIPTION

This high voltage MOSFET uses an advanced termination scheme to provide enhanced voltage-blocking capability without degrading performance over time. In addition, this advanced MOSFET is designed to withstand high energy in avalanche and commutation modes. The new energy efficient design also offers a drain-to-source diode with a fast recovery time. Designed for high voltage, high speed switching applications in power supplies, converters and PWM motor controls, these devices are particularly well suited for bridge circuits where diode speed and commutating safe operating areas are critical and offer additional and safety margin against unexpected voltage transients.

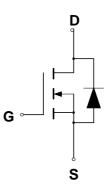
FEATURES

- Robust High Voltage Termination
- Avalanche Energy Specified
- Source-to-Drain Diode Recovery Time Comparable to a Discrete Fast Recovery Diode
- Diode is Characterized for Use in Bridge Circuits
- ▶ I_{DSS} and V_{DS}(on) Specified at Elevated Temperature
- Isolated Mounting Hole Reduces Mounting Hardware

PIN CONFIGURATION



SYMBOL



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS

Symbol	Value	Unit
I _D	20	А
I _{DM}	60	
V _{GS}	±20	V
V_{GSM}	±40	V
PD	250	W
	2.00	W /°C
T _J , T _{STG}	-55 to 150	°C
E _{AS}	276	mJ
θις	0.50	°C/W
θ_{JA}	40	
ΤL	260	°C
	I _D I _{DM} V _{GS} V _{GSM} P _D TJ, T _{STG} E _{AS} θ _{JC} θ _{JA}	I _D 20 I _{DM} 60 V _{GS} ±20 V _{GSM} ±40 P _D 250 2.00 2.00 T _J , T _{STG} -55 to 150 E _{AS} 276 θ _{JC} 0.50 θ _{JA} 40

(1) Pulse Width and frequency is limited by TJ(max) and thermal response



ORDERING INFORMATION

Part Number	art Number Package	
CMT20N50N3P	TO-3P	

ELECTRICAL CHARACTERISTICS

Unless otherwise specified, T_J = 25 $^\circ\!\mathrm{C}$.

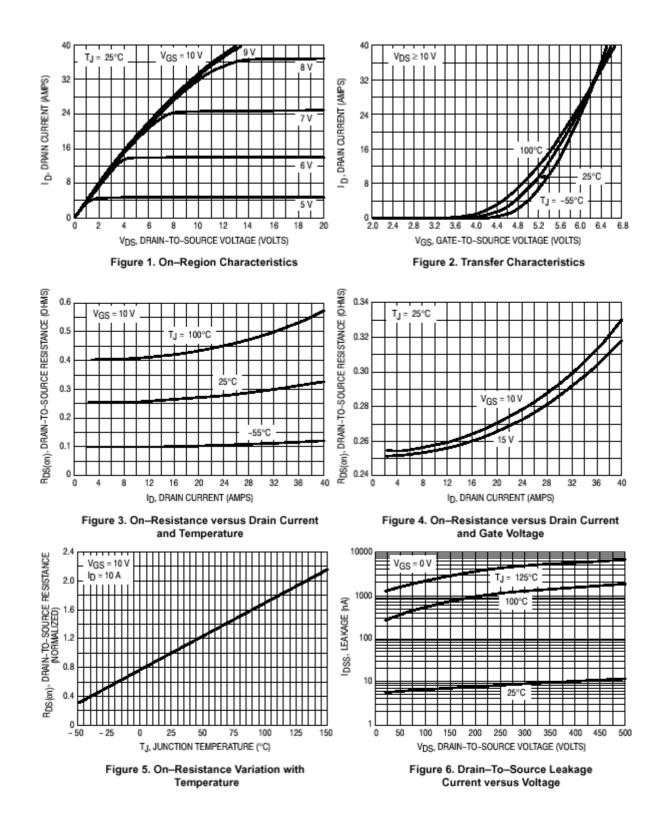
			CMT20N50			
Characteristic		Symbol	Min	Тур	Max	Units
Drain-Source Breakdown Voltage		V _{(BR)DSS}	500			V
$(V_{GS} = 0 V, I_D = 250 \mu A)$						
Drain-Source Leakage Current		I _{DSS}				mA
$(V_{DS} = 500 \text{ V}, V_{GS} = 0 \text{ V})$					0.05	
$(V_{DS} = 500 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 125^{\circ}\text{C})$					0.1	
Gate-Source Leakage Current-Forward		I _{GSSF}			100	nA
$(V_{gsf} = 20 \text{ V}, V_{DS} = 0 \text{ V})$						
Gate-Source Leakage Current-Reverse		I _{GSSR}			100	nA
$(V_{gsr} = 20 \text{ V}, V_{DS} = 0 \text{ V})$						
Gate Threshold Voltage		$V_{GS(th)}$	2.0		4.0	V
$(V_{DS} = V_{GS}, I_D = 250 \ \mu A)$						
Static Drain-Source On-Resistance (V _{GS} =	10 V, I _D = 10A) *	R _{DS(on)}			0.25	Ω
Drain-Source On-Voltage (V _{GS} = 10 V)		V _{DS(on)}		5.75	6.0	V
(I _D = 20 A)						
Forward Transconductance (V_{DS} = 50 V, I_{D}	= 10A) *	g fs	11			mhos
Input Capacitance	$(V_{DS} = 25 V. V_{GS} = 0 V.$	C _{iss}		3880	6950	pF
Output Capacitance	$(v_{DS} - 23 v, v_{GS} - 0 v, f = 1.0 \text{ MHz})$	C _{oss}		452	920	pF
Reverse Transfer Capacitance	1 – 1.0 Mi 12)	C _{rss}		96	140	pF
Turn-On Delay Time	(V _{DD} = 250 V. I _D = 20 A.	t _{d(on)}		29	55	ns
Rise Time	$(V_{DD} = 250 \text{ V}, \text{ I}_D = 20 \text{ A},$ $V_{GS} = 10 \text{ V},$	tr		90	165	ns
Turn-Off Delay Time	$v_{GS} = 10 v,$ $R_G = 9.1\Omega) *$	t _{d(off)}		97	190	ns
Fall Time	$R_{\rm G} = 9.1\Omega$)	t _f		84	170	ns
Total Gate Charge		Qg		100	132	nC
Gate-Source Charge	$(V_{DS} = 400 \text{ V}, I_D = 20 \text{ A},$	Q _{gs}		20		nC
Gate-Drain Charge	V _{GS} = 10 V)*	Q _{gd}		44		nC
Internal Drain Inductance		L _D		5.0		nH
(Measured from the drain lead 0.25" from	n package to center of die)					
Internal Drain Inductance		Ls		13		nH
(Measured from the source lead 0.25" from package to source bond pad)						
SOURCE-DRAIN DIODE CHARACTERIS	TICS					
Forward On-Voltage(1)	(1	V _{SD}			1.5	V
Forward Turn-On Time	$(I_{\rm S} = 20 \text{ A},$	t _{on}		**		ns
Reverse Recovery Time	$d_{IS}/d_{t} = 100A/\mu s)$	t _{rr}		431		ns

* Pulse Test: Pulse Width \leq 300µs, Duty Cycle \leq 2%

** Negligible, Dominated by circuit inductance



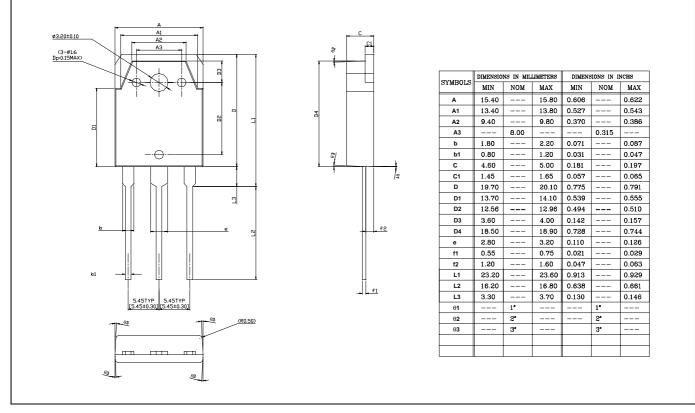
TYPICAL ELECTRICAL CHARACTERISTICS





PACKAGE DIMENSION







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HsinChu Headquarter	Sales & Marketing			
5F-1, No. 11, Park Avenue II,	11F, No. 306-3, SEC. 1, Ta Tung Road,			
Science-Based Industrial Park,	Hsichih, Taipei Hsien 221, Taiwan			
HsinChu City, Taiwan				
TEL: +886-3-567 9979	TEL: +886-2-8692 1591			
FAX: +886-3-567 9909	FAX: +886-2-8692 1596			